

<Full SiC Power Modules>

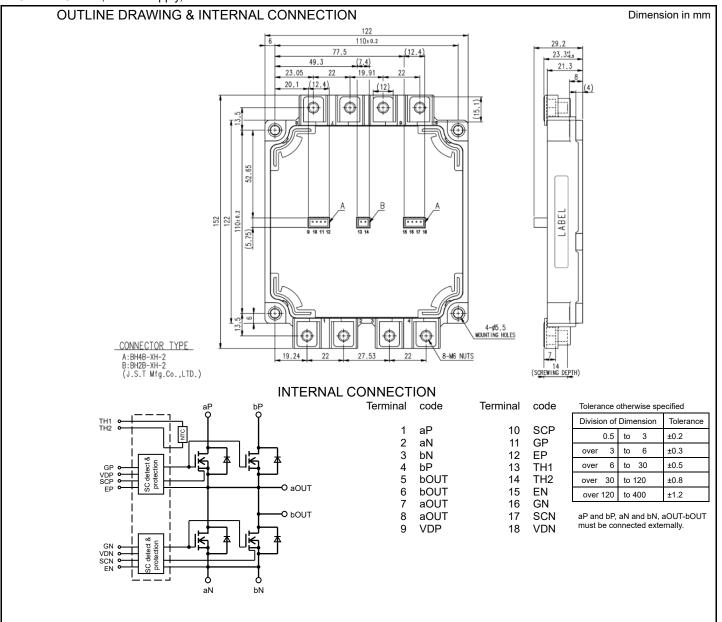
FMF1200DXZ-24B

HIGH POWER SWITCHING USE INSULATED TYPE

Drain current I _D 1 2 0 0 A
Drain-Source voltage V _{DSX} 1 2 0 0 V
Maximum junction temperature T _{vjmax} 175 °C
 Silicon Carbide MOSFET + Silicon Carbide Schottky Barrier Diode
●Flat base Type
•Copper base plate
RoHS Directive compliant
 Recognized under UL1557, File E323585

APPLICATION

AC Motor Control, Power supply, etc.



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MAXIMUM RATINGS (Tvi =25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit
V _{DSX}	Drain-source voltage	V _{GS} =-15 V	1200	V
V _{GSS}	Gate-source voltage	D-S short-circuited	±20	V
ID	Drain aumant	DC, T _C =61°C (Note.2)	1200	•
I _{DRM}	Drain current	Pulse, Repetitive (Note.3), Tvj=150°C(Note.4)	1800	A
P _{tot}	Total power dissipation	Tc=25 °C (Note. 2)	4540	W
Is (Note.1)	Querra and the	DC	1200	•
ISRM (Note.1)	Source current	Pulse, Repetitive (Note.3), Tvj=150°C	1800	A
Visol	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	5000	V
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload) (Note.10)	175	°C
Tvjop	Operating junction temperature	Continuous operation (under switching) (Note.10)	-40~+150	°C
T _{cmax}	Maximum case temperature	(Note.2, 10)	125	°C
T _{stg}	Storage temperature	-	-40~+125	°C

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Sumbol	Itom	Conditions (note9)			Limits		Linit
Symbol	Item Conditions (note9)		.,	Min.	Тур.	Max.	Unit
		V _{DS} =V _{DSX} , V _{GS} =-15 V		-	-	12.5	
I _{DSX}	Drain-source cut-off current	V _{DS} =800V, V _{GS} =-15 V		-	-	1.25	mA
$V_{GS(th)}$	Gate-source threshold voltage	I _D =360 mA, V _{DS} =10 V		1.8	2.5	3.2	V
I _{GSS}	Gate-source leakage current	V _{GS} =V _{GSS} , D-S short-circuited		-	-	0.5	μA
			T _{vj} =25 °C	-	1.60	2.36	
V _{DS(on)}	Drain-source on-state voltage	I _D =1200 A, V _{GS} =15V (Note.6)	T _{vj} =125 °C	-	2.03	-	V
(terminal)			T _{vj} =150 °C	-	2.12	-	
			T _{vj} =25 °C	-	1.30	-	
V _{DS(on)}	Drain-source on-state voltage	I _D =1200 A, V _{GS} =15V (Note.6)	T _{vj} =125 °C	-	1.73	-	V
(chip)	ip)		T _{vj} =150 °C	-	1.82	-	
		I_D =1200 A, V_{GS} =15V (Note.6)	T _{vj} =25 °C	-	1.1	-	
r _{DS(on)}	Drain-source on-state resistance		T _{vj} =125 °C	-	1.4	-	mΩ
(chip)			T _{vj} =150 °C	-	1.5	-	
Ciss	Input capacitance		V _{DS} =10 V, V _{GS} =0V			-	
Coss	Output capacitance	V _{DS} =10 V, V _{GS} =0V				-	nF
Crss	Reverse transfer capacitance			-	5.3	-	
Q_{G}	Gate charge	V _{DD} =600 V, I _D =1200 A, V _{GS} =0→1	5 V	-	2570	-	nC
t _{d(on)}	Turn-on delay time			-	350	-	
tr	Rise time			-	120	-	
$t_{d(off)}$	Turn-off delay time			-	440	-	ns
t _f	Fall time	V _{DD} =600 V, I _D =1200 A, V _{GS} =±15 R _G =1.0Ω, L _{s ext} =16nH, Inductive		-	80	-	
Eon	Turn-on switching energy		ioau, pei puise	-	66	-	
Eoff	Turn-off switching energy			-	54	-	mJ
Qc	Drain-source charge			-	6.3	-	μC
			T _{vj} =25 °C	-	1.87	2.40	
V _{SD} ^(Note.1)	Source-drain voltage	I _S =1200 A ^(Note.6) V _{GS} =-15 V	T _{vj} =125 °C	-	2.63	-	V
(terminal)		VGS13 V	T _{vj} =150 °C	-	2.82	-	
			T _{vj} =25 °C	-	1.57	-	
V _{SD} (Note.1)	Source-drain voltage	I _S =1200 A ^(Note.6) V _{GS} =-15 V	T _{vj} =125 °C	-	2.33	-	V
(chip)		V _{GS} 15 V	T _{vj} =150 °C	-	2.52	-	
R _{DD'+SS'}	Internal lead resistance	P-EP, OUT-EN terminals, per sv	P-EP, OUT-EN terminals, per switch		0.25	-	mΩ
Ls	Internal stray inductance	P-N			15	-	nH
r _{g(on)}	Internal gate resistance (on)	Per switch		-	0.65	-	Ω
r _{g(off)}	Internal gate resistance (off)	Per switch		-	3.07	-	Ω

HIGH POWER SWITCHING USE INSULATED TYPE

THERMAL RESISTANCE CHARACTERISTICS

Currente e l	ltom	Conditions	Limits			Linit
Symbol	Symbol Item		Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal resistance ^(Note. 2)	Junction to case, per inverter switch	-	-	33	K/kW
R _{th(j-c)D}		Junction to case, per inverter FWD	-	-	47	N/KVV
Б	Contact thermal resistance ^(Note.2)	Case to heat sink, per 1 module,		6		K/kW
$R_{th(c-s)}$		Thermal grease applied (Note.8, 10)	-	0	-	IV/KVV

NTC THERMISTOR PART

Symbol	Itom	Conditions		Unit		
	Item	Conditions	Min.	Тур.	Max.	Unit
R ₂₅	Zero-power resistance	T _C =25 °C ^(Note.2)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	Tc=100 °C ^(Note.2) ,R ₁₀₀ =493 Ω	-7.3	-	+7.8	%
B _(25/50)	B-constant	Approximate by equation (Note.7)	-	3375	-	К
P ₂₅	Power dissipation	T _C =25 °C ^(Note.2)	-	-	10	mW

MECHANICAL CHARACTERISTICS

Symbol	ltem	Conditions			Limits		Unit
Symbol	lien	Conditions	Conditions		Тур.	Max.	Unit
Mt	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N∙m
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	IN TH
m	mass	-		-	920	-	g
da	Clearance			10.0	-	-	mm
ds	Creepage distance			17.5	-	-	mm
ec	Flatness of base plate	On the centerline X, Y (Note.5)		-100	-	+120	μm
-	Connector insertion force	2 pin type		0	-	25	N
		4 pin type		0	-	35	Ν

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU)2015/863.

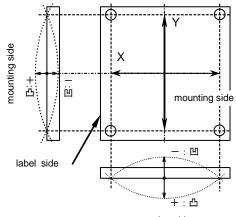
Note1. Represent ratings and characteristics of the anti-parallel, source-drain free wheeling diode (FWD).

2. Case temperature (T_c) and heat sink temperature (T_s) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) does not exceed T_{vjmax} rating.

4. Junction temperature (T_{vj}) should not increase beyond T_{vjmax} rating.

5. The base plate (mounting side) flatness measurement points (X, Y) are as follows of the following figure.



mounting side

6. Pulse width and repetition rate should be such as to cause negligible temperature rise.

7.
$$B_{(25/50)} = ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$$

 $R_{25}\!\!:$ resistance at absolute temperature T_{25} [K]; $T_{25}\!\!=\!\!25$ [°C]+273.15=298.15 [K]

 $R_{50}:$ resistance at absolute temperature T_{50} [K]; $T_{50}\text{=}50$ [°C]+273.15=323.15 [K]

8. Reference value. Thermally conductive grease of λ =0.9 W/(m·K) and thickness D_(C-S)=100µm.

9. Per switch (ex. Tr1 chips total in page.6)

10. Long term performance related to thermal conductive grease (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition (T_{vj max}, T_{vj op}, T_{C max}) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

<Full SiC Power Modules> FMF1200DXZ-24B HIGH POWER SWITCHING USE

INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

Symbol	ltem	Conditions	Limits			1.1
	item	Conditions	Min.	Тур.	Max.	Unit
V _{DD}	(DC) Supply voltage	Applied across aP -aN, bP-bN terminals	-	600	850	V
VD	DC supply voltage (control)	Applied across VDP-EP, VDN-EN terminals	13.5	15.0	16.5	V
V _{GS(+)}	Gate-Source positive drive voltage	Applied across GP-EP, GN-EN terminals	13.5	15.0	16.5	V
V _{GS(-)}	Gate-Source negative drive voltage	Applied across GP-EP, GN-EN terminals	-16.5	-15.0	-7.0	V
R _G	External gate resistance (Note.11)	Per switch	1.0	-	5.0	Ω
f _c	Switching frequency	V _{GS} =±15V, R _G =1.0Ω, V _{DD} =600V, T _{vj} =150°C	-	-	50	kHz
$t_{d(SCoff)}$	Gate cutoff delay time after SC output	V _{GS} =15V, R _G =1.0Ω, V _{DD} ≦850V, T _{vj} =150°C	-	-	3	μs

Note 11. The value of external gate resistance should be considered the surge voltage not to exceed the rating voltage in the worst system condition.

SHORT CIRCUIT DETECTION & PROTECTION CHARACTERISTICS

Symbol	ltem	Conditions	Limits			Unit
	item	Conditions	Min.	Тур.	Max.	Unit
I _{D(SC)}	SC detect drain current	T _{vj} =150°C, V _{GS} =15V	1800	2400	-	Α
$t_{d(SC)}$	SC detect delay time	T _{vj} =150°C, V _{GS} =15V, R _G =1.0 Ω	-	1	-	μs
$V_{GS(SC)}$	SC protection gate limit voltage	T _{vj} =150°C, V _{GS} =15V, R _G =1.0 Ω	-	5.8	-	V
R1	SC protection gate limit resistance	-	-	0.50	-	Ω

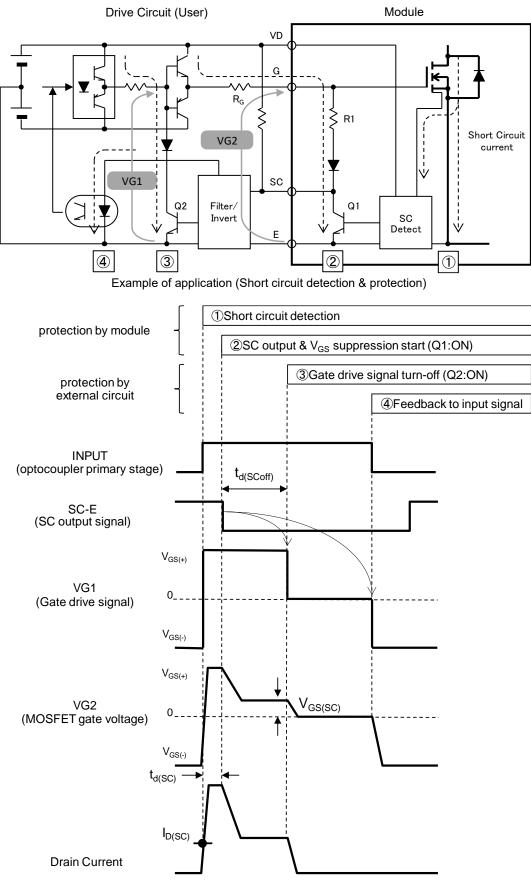
Refer to the circuit in page.5

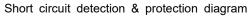
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HIGH POWER SWITCHING USE INSULATED TYPE

SHORT CIRCUIT DETECTION & PROTECTION

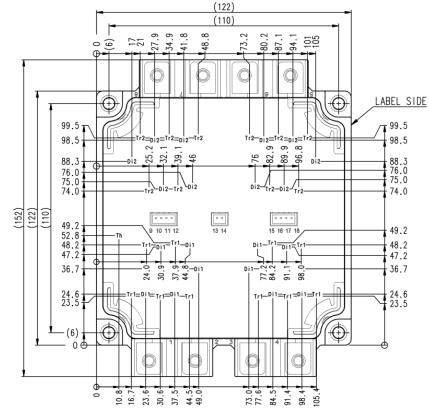




HIGH POWER SWITCHING USE INSULATED TYPE

CHIP LOCATION (Top view)

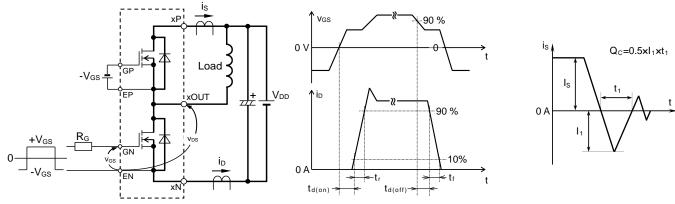
Dimension in mm, tolerance: ±1 mm



Tr1,Tr2: SiC-MOSFET, Di1,Di2: SiC-SBD, Th: NTC thermistor

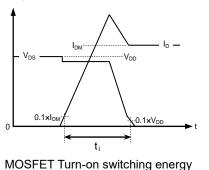
HIGH POWER SWITCHING USE INSULATED TYPE

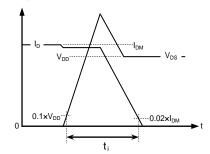
TEST CIRCUIT AND WAVEFORMS



Switching characteristics test circuit and waveforms(x: connected a* and b*)

Qc test waveform





MOSFET Turn-off switching energy

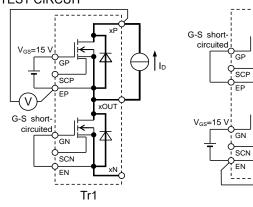
Turn-on / Turn-off switching energy test waveforms (Integral time instruction drawing)

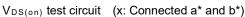
V

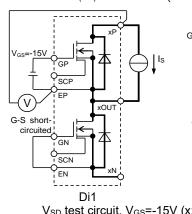
ID

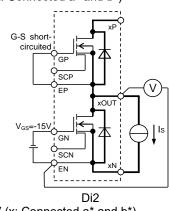
OU.

TEST CIRCUIT



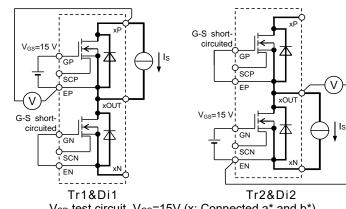






Tr2

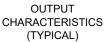
V_{SD} test circuit, V_{GS}=-15V (x: Connected a* and b*)

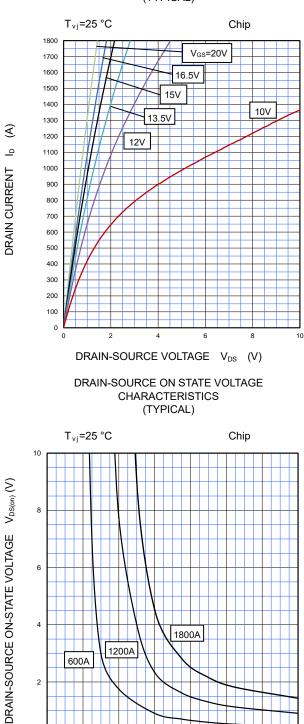


V_{SD} test circuit, V_{GS}=15V (x: Connected a* and b*)

HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES





1800A

14

16

18

20

1200A

10

12

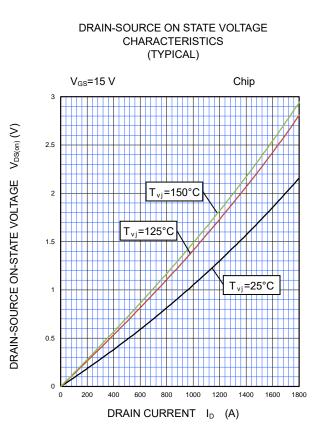
GATE-SOURCE VOLTAGE V_{GS} (V)

600A

8

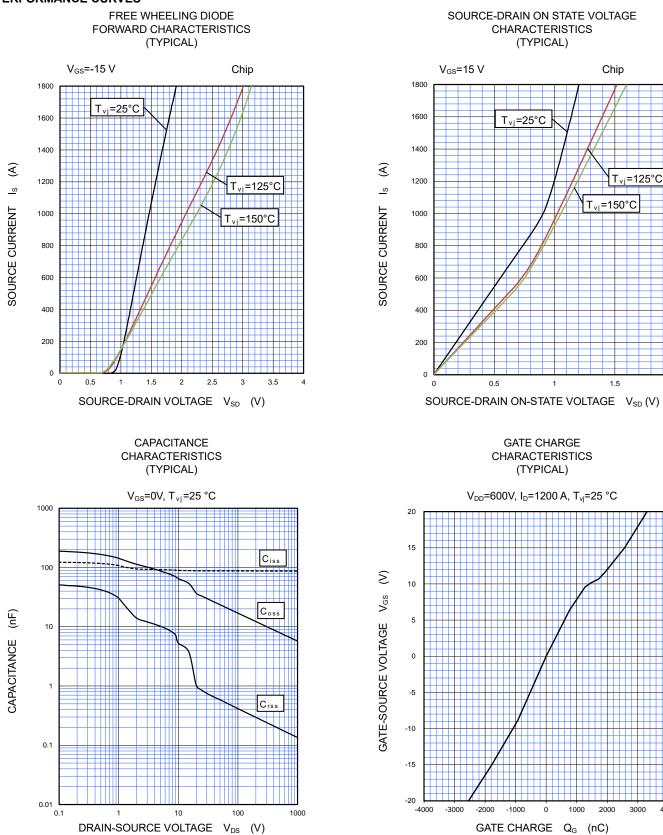
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HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES

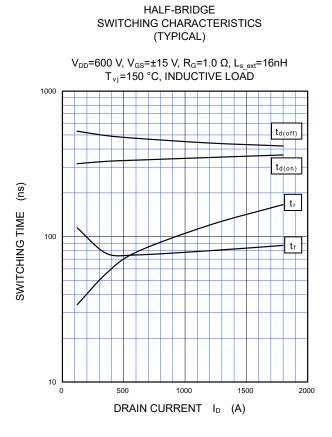


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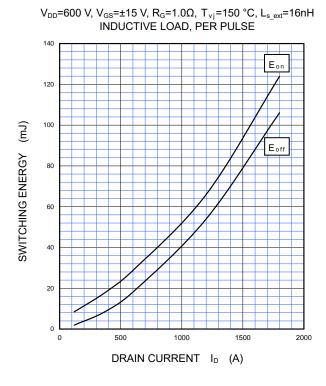
4000

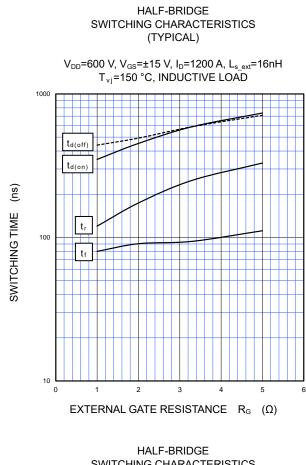
HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES



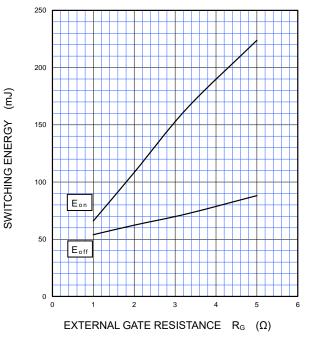
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)





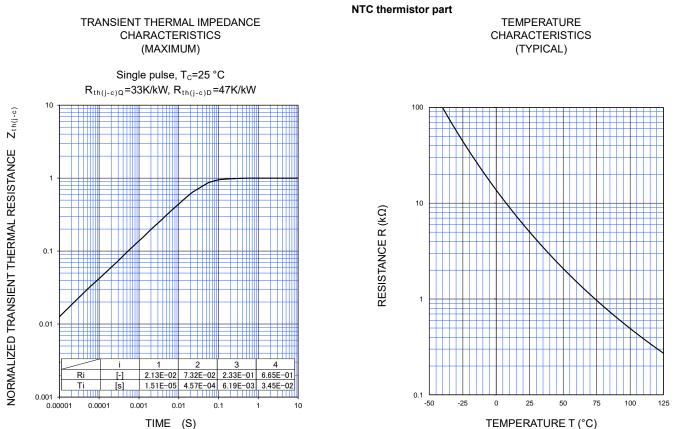
SWITCHING CHARACTERISTICS (TYPICAL)

 $\label{eq:VDD} V_{DD} \mbox{=} 600 \mbox{ V, } V_{GS} \mbox{=} \mbox{\pm} 15 \mbox{ V, } I_D \mbox{=} 1200 \mbox{ A, } T_{vj} \mbox{=} 150 \mbox{ °C, } L_{s_ext} \mbox{=} 16n \mbox{H} \\ \mbox{INDUCTIVE LOAD, PER PULSE}$



<Full SiC Power Modules> FMF1200DXZ-24B HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

<Full SiC Power Modules> FMF1200DXZ-24B HIGH POWER SWITCHING USE INSULATED TYPE

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